Search Notes



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Applicant(s)/Patent Under Reexamination

VAN SCHAIJK ET AL.

Examiner

Hsieh, Hsin-Yi (Steven)

Art Unit

2811

SEARCHED

Class	Subclass	Date	Examiner
257	326, E29.305	Updated	HH
		06/01/11	

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Search Notes	Date	Examiner
Update Search: East search and subclass search	06/01/11	HH
Consulted with the Primary Examiner Shouxiang Hu to re-open the application	05/25/11	HH

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner

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